



**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**
FORM PTO-1449 (modified)

Sheet 1 of 3

Application No.	10/529,786
Filing Date	March 30, 2005
First Named Inventor	DeVRIES, Hindrick
Group Art Unit	1792
Examiner Name	BURKHART, Elizabeth A.
Attorney Docket No.	2602-0009
Confirmation No.	1486

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document No.	Publication/ Issue Date	Name of Patentee or Applicant of Cited Document
	1-1	US-5414324	1995/05/09	Roth et al.
	1-2	US-5585147	1996/12/17	Ogawa et al.
	1-3	US-6299948	2001/10/09	Gherardi et al.
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Examiner
Signature

Date
Considered

*Examiner: Initial if reference was considered, whether or not citation is in conformance with MPEP 609. Draw a line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /E.B./



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FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document No.	Publication Date	Name of Patentee or Applicant of Cited Document	Notes
	2-1	EP 0699954	1996/03/06	Glocker, David A. et al.	
	2-2	EP 0790525	1997/08/20	Romach, Mark M. et al.	
	2-3	EP 0821273	1998/01/28	Glocker, David A. et al.	
	2-4	JP 11005857	1999/12/01	Akira, Nishiwaki	
	2-5	WO 0223960	2002/03/21	Yializis, Angelo et al.	
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/Elizabeth Burkhart/

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12/01/2008

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